

UTC MMBT5401 PNP EPITAXIAL SILICON TRANSISTOR

HIGH VOLTAGE SWITCHING TRANSISTOR

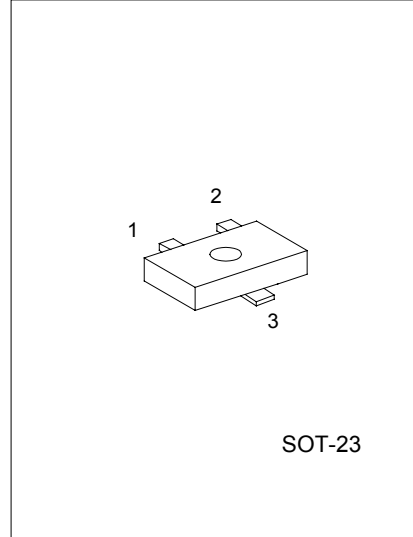
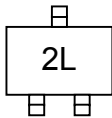
FEATURES

- *Collector-Emitter Voltage:
 $V_{CE0} = -150V$
- *Collector Dissipation:
 $P_c(\max) = 350mW$
- *High current gain

APPLICATIONS

- *Telephone Switching Circuit
- *Amplifier

MARKING



1:EMITTER 2:BASE 3:COLLECTOR

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$, unless otherwise specified)

PARAMETER	SYMBOL	RATING	UNIT
Collector-base voltage	V_{CB0}	-160	V
Collector-emitter voltage	V_{CE0}	-150	V
Emitter-base voltage	V_{EB0}	-5	V
Collector dissipation	P_c	350	mW
Collector current	I_c	-600	mA
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{STG}	-55 ~ +150	$^\circ C$

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$, unless otherwise specified)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Collector-base breakdown voltage	BV_{CB0}	$I_c = -100\mu A, I_E = 0$	-160			V
Collector-emitter breakdown voltage	BV_{CE0}	$I_c = -1mA, I_B = 0$	-150			V
Emitter-base breakdown voltage	BV_{EB0}	$I_E = -10\mu A, I_c = 0$	-6			V
Collector cut-off current	I_{CB0}	$V_{CB} = -120V, I_E = 0$			-50	nA
Emitter cut-off current	I_{EB0}	$V_{EB} = -3V, I_c = 0$			-50	nA
DC current gain(note)	h_{FE1} h_{FE2} h_{FE3}	$V_{CE} = -5V, I_c = -1mA$ $V_{CE} = -5V, I_c = -10mA$ $V_{CE} = -5V, I_c = -50mA$	80 80 80		400	
Collector-emitter saturation voltage	$V_{CE(sat)}$	$I_c = -10mA, I_B = -1mA$ $I_c = -50mA, I_B = -5mA$			-0.2 -0.5	V
Base-emitter saturation voltage	$V_{BE(sat)}$	$I_c = -10mA, I_B = -1mA$ $I_c = -50mA, I_B = -5mA$			-1 -1	V

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(continued)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Current gain bandwidth product	f_T	$V_{CE}=-10V, I_C=-10mA, f=100MHz$	100		400	MHz
Output capacitance	C_{ob}	$V_{CB}=-10V, I_E=0$ $f=1MHz$			6.0	pF
Noise Figure	NF	$I_C=-0.25mA, V_{CE}=-5V$ $R_s=1k\Omega, f=10Hz$ to $15.7kHz$			8	dB

Note: Pulse test: $PW<300\mu s$, Duty Cycle $<2\%$

TYPICAL PARAMETERS PERFORMANCE

